## Application/Control No. Applicant(s)/Patent Under Reexamination 10/822,627 XIE ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 1609 Luke E. Karpinski U.S. PATENT DOCUMENTS Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 424/489 US-5,478,577 A 12-1995 Sackler et al. Α 424/473 US-6,372,255 B1 04-2002 Saslawski et al. В 424/468 11-2002 Campbell et al. US-6,485,746 B1 С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х